

<b>Search Notes</b>				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/706,278	IGARASHI ET AL.	
				Examiner	Art Unit	
				Duc M. Nguyen	2618	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
455	313	4/28/2006	DN	EAST	4/28/2006	DN
	326					
	333					
327	102					
	113	↓	↓			
329	315	4/28/2006	DN			
<i>Update</i>		<i>10/4/06</i>	<i>dn</i>			
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner		DATE	EXMR
<i>claim</i>	<i>Search</i>	<i>10/4/06</i>	<i>dn</i>			